CITATION IN AN APPLICATION IN AN APPLICATION IN AN APPLICANT Atsushi TANAKA, et al.  (PTO-1449)  U.S. PATENT DOCUMENTS  EXAMINER'S 43890-510  09/843,032  APPLICANT Atsushi TANAKA, et al.  FILING DATE April 27, 2001	
U.S. PATENT DOCUMENTS	
EXAMINER'S FII	
INITIALS PATENT NO. DATE NAME CLASS SUBCLASS	LING DATE
FOREIGN PATENT DOCUMENTS	
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2001-69141 3/16/2001 Japan (w/ English Abstract) — — —	
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)	
EXAMINER DATE CONSIDERED / 15/04	

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.